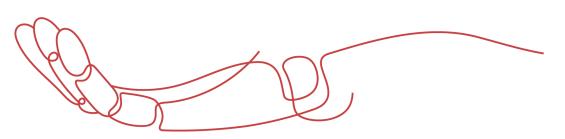




PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at







Datasheet Resource

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

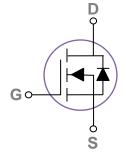
BVDSS	RDSON	ID
30V	12m Ω	35A

Features

- 30V,35A, $RDS(ON) = 12m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

PPAK3X3





Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	±20	V
I_	Drain Current – Continuous (Tc=25°C)	35	А
lD	Drain Current – Continuous (Tc=100°C)	22	А
I _{DM}	Drain Current – Pulsed1	140	А
EAS	Single Pulse Avalanche Energy ²	13	mJ
IAS	Single Pulse Avalanched Current ²	16	А
D	Power Dissipation (T _C =25°C)	27	W
P _D	Power Dissipation – Derate above 25°C	0.21	W/°C
Т _{STG}	Storage Temperature Range	-55 to 150	℃
ΤJ	Operating Junction Temperature Range	-55 to 150	℃

Thermal Characteristics

Symbol	Symbol Parameter		Max.	Unit	
Reja	Thermal Resistance Junction to ambient		62	°C/W	
Rejc	Thermal Resistance Junction to Case		4.6	°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.04		V/°C
IDSS	Drain-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	uA
	Diam-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125°C			10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistance ³	Static Drain Source On Registance ³	V _{GS} =10V , I _D =10A		9.4	12	mΩ
	Static Diain-Source On-Nesistance	V _{GS} =4.5V , I _D =5A		13	18	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA		1.8	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-4		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =3A		6.4		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3, 4}			7.4	12	
Q_{gs}	Gate-Source Charge ^{3, 4}	V _{DS} =15V , V _{GS} =4.5V , I _D =5A		2.3	5	nC
Q_{gd}	Gate-Drain Charge ^{3, 4}			3	6	
$T_{d(on)}$	Turn-On Delay Time ^{3, 4}			3.8	7	
Tr	Rise Time ^{3, 4}	V_{DD} =15 V , V_{GS} =10 V , R_{G} =6 Ω		10	19	20
T _{d(off)}	Turn-Off Delay Time ^{3, 4}	I _D =1A		22	42	ns
Tf	Fall Time ^{3, 4}			6.6	13	
Ciss	Input Capacitance			620	900	
Coss	Output Capacitance	V _{DS} =25V , V _{GS} =0V , F=1MHz		85	125	pF
Crss	Reverse Transfer Capacitance			60	90	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.8	5.6	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	Va_Va_0V Force Current			35	А
Ism	Pulsed Source Current ³	V _G =V _D =0V , Force Current			70	Α
V _{SD}	Diode Forward Voltage ³	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =16A., R_{G} =25 Ω ,Starting T_{J} =25°C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



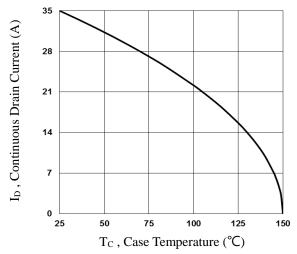


Fig.1 Continuous Drain Current vs. Tc

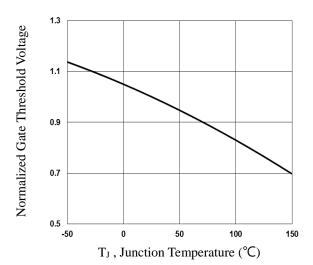


Fig.3 Normalized V_{th} vs. T_J

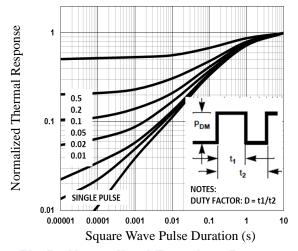


Fig.5 Normalized Transient Response

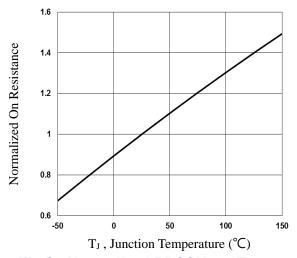


Fig.2 Normalized RDSON vs. T_J

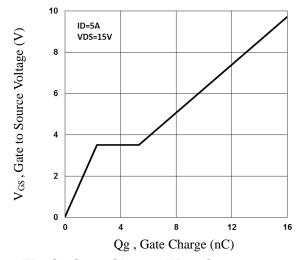


Fig.4 Gate Charge Waveform

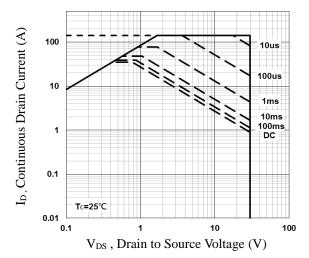


Fig.6 Maximum Safe Operation Area



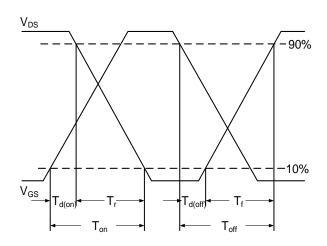


Fig.7 Switching Time Waveform

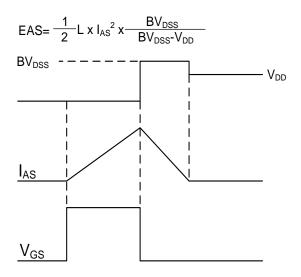
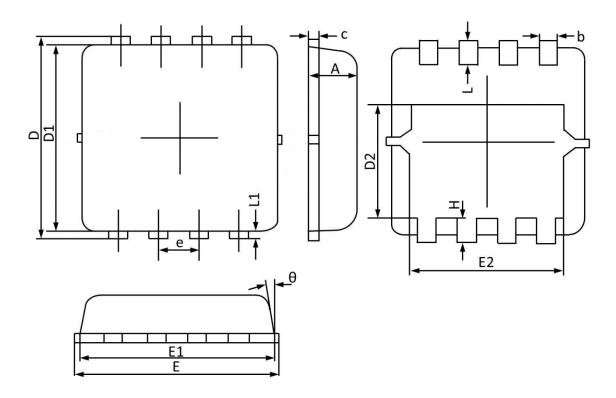


Fig.8 EAS Waveform



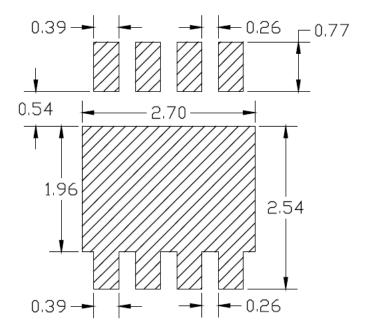
PPAK3x3 PACKAGE INFORMATION



Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	MAX	MIN	MAX	MIN
Α	0.900	0.700	0.035	0.028
b	0.350	0.250	0.014	0.010
С	0.250	0.100	0.010	0.004
D	3.500	3.050	0.138	0.120
D1	3.200	2.900	0.126	0.114
D2	1.950	1.350	0.077	0.053
E	3.400	3.000	0.134	0.118
E1	3.300	2.900	0.130	0.114
E2	2.600	2.350	0.102	0.093
е	0.65	BSC	0.02	6BSC
Н	0.750	0.300	0.030	0.012
L	0.600	0.300	0.024	0.012
L1	0.200	0.060	0.008	0.002
θ	14°	6°	14°	6°



PPAK3X3 RECOMMENDED LAND PATTERN





Attention

- 1, Any and all JGSEMI products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, orother applic ations whose failure can be reasonably expected to result in serious physical or material damage. Consult with your JGSEMI representative nearest you before using any JGSEMI products described or contained herein in such applications.
- 2,JGSEMI assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all JGSEMI products described or contained herein.
- 3, Specifications of any and all JGSEMI products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To ver ify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- 4,In the event that any or all JGSEMI products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported wit hout obtaining the export license from the authorities concerned in accordance with the above law.
- 5, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanic al, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of JGSEMI Semiconductor CO., LTD.
- 6, Any and all information described or contained herein are subject to change without notice due to product technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the JGSEMI product that you Intend to use.